BLF8G22LS-240

Power LDMOS transistor

Rev. 3 — 7 March 2013

Product data sheet

1. Product profile

1.1 General description

240 W LDMOS power transistor for base station applications at frequencies from 2110 MHz to 2170 MHz.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25$ °C in a common source class-AB production test circuit.

Test signal	f	I _{Dq}	V _{DS}	P _{L(AV)}	Gp	η _D	ACPR
	(MHz)	(mA)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA	2110 to 2170	2000	28	55	19	28.5	-30 ^[1]

^[1] Test signal: 3GPP test model 1; 64 DPCH; PAR = 8.4 dB at 0.01 % probability on CCDF; carrier spacing 5 MHz.

1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low R_{th} providing excellent thermal stability
- Designed for broadband operation
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

RF power amplifiers for base stations and multi carrier applications in the 2110 MHz to 2170 MHz frequency range



2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol	
1	drain			
2	gate		1 	
3	source	[1]	2 - 3 sym112	

^[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Packaç	ge	
	Name	Description	Version
BLF8G22LS-240	-	earless flanged ceramic package; 2 leads	SOT502B

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		-0.5	+13	V
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	225	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-c)}	thermal resistance from junction to case	$T_{case} = 80 ^{\circ}\text{C}; P_{L} = 55 \text{W (CW)};$ $V_{DS} = 28 \text{V}; I_{Dq} = 2000 \text{mA}$	0.263	K/W

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 3.3 \text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 330 \text{ mA}$	1.55	1.77	2.25	V
I _{DSS}	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V}$	-	-	4.2	μΑ
I _{DSX}	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $V_{DS} = 10 \text{ V}$	-	60	-	Α
I _{GSS}	gate leakage current	$V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	420	nA
9 _{fs}	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 330 \text{ mA}$	-	2.2	-	S
R _{DS(on)}	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 11.55 \text{ A}$	-	45	-	mΩ

Table 7. RF characteristics

Test signal: 2-carrier W-CDMA; PAR = 8.4 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1-64 DPCH; f_1 = 2112.5 MHz; f_2 = 2117.5 MHz; f_3 = 2162.5 MHz; f_4 = 2167.5 MHz; RF performance at V_{DS} = 28 V; I_{Dq} = 2000 mA; T_{case} = 25 °C; unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G_p	power gain	$P_{L(AV)} = 55 \text{ W}$	18	19	-	dB
η_{D}	drain efficiency	$P_{L(AV)} = 55 \text{ W}$	23	28.5	-	%
RL_{in}	input return loss	$P_{L(AV)} = 55 \text{ W}$	-	-17	-6	dB
$ACPR_{5M}$	adjacent channel power ratio (5 MHz)	$P_{L(AV)} = 55 \text{ W}$	-	-30	-25	dBc

7. Test information

7.1 Ruggedness in class-AB operation

The BLF8G22LS-240 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 28 V; I_{Dq} = 2000 mA; P_{L} = 200 W (CW); f = 2110 MHz.

7.2 Impedance information

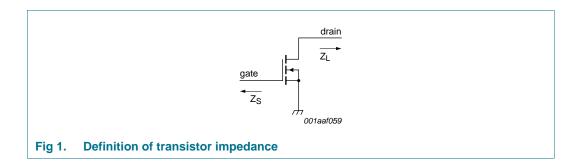
Table 8. Typical impedance information

Measured load pull data. Typical values unless otherwise specified. Z_S and Z_L defined in Figure 1.

f	Z _S [1]	Z _L
(MHz)	(Ω)	(Ω)
2110	0.8 - j4.2	2.1 – j2.4
2140	1.0 – j4.4	2.2 – j2.4
2170	1.1 – j4.7	2.5 – j2.4

^[1] Straight lead.

BLF8G22LS-240



7.3 Test circuit

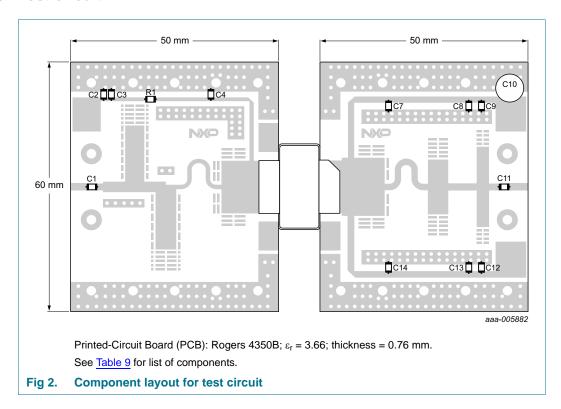
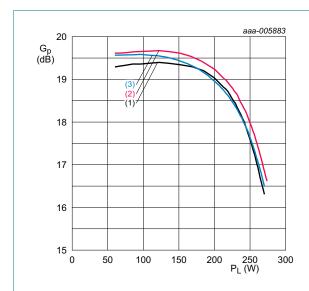


Table 9. List of components For test circuit, see Figure 2.

Component	Description	Value	Remarks
C1, C4, C7, C11, C14	multilayer ceramic chip capacitor	8.2 pF	ATC100B
C2	multilayer ceramic chip capacitor	1 μF	Murata
C3	multilayer ceramic chip capacitor	100 nF	Murata
C8, C13	multilayer ceramic chip capacitor	200 nF, 50 V	Murata
C9, C12	multilayer ceramic chip capacitor	$4.7~\mu F,50~V$	Murata
C10	electrolytic capacitor	$>$ 470 μF , 50 V	
R1	resistor	2.2 Ω, 1 %	SMD 0805

7.4 Graphical data

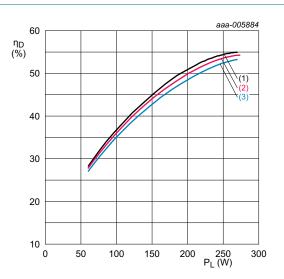
7.4.1 Pulsed CW



 V_{DS} = 28 V; I_{Dq} = 2000 mA; t_p = 100 $\mu s;$ δ = 10 %.

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 3. Power gain as a function of load power; typical values

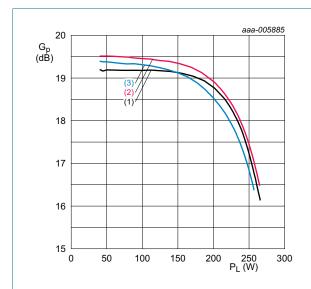


 V_{DS} = 28 V; I_{Dq} = 2000 mA; t_p = 100 $\mu s;$ δ = 10 %.

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 4. Drain efficiency as a function of load power; typical values

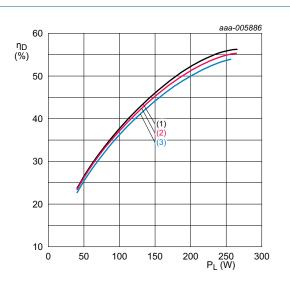
7.4.2 CW



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 5. Power gain as a function of load power; typical values

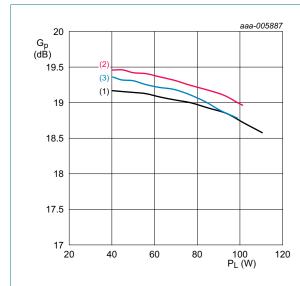


 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 6. Drain efficiency as a function of load power; typical values

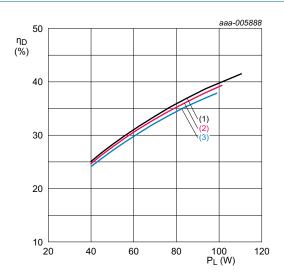
7.4.3 1-Carrier W-CDMA



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170MHz

Fig 7. Power gain as a function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

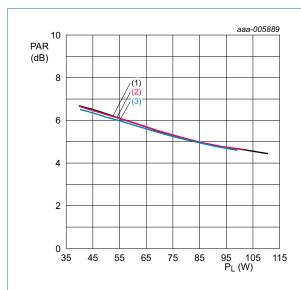
- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 8. Drain efficiency as a function of load power; typical values

BLF8G22LS-240

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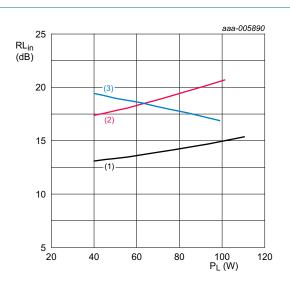
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 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 9. Peak-to-average power ratio as a function of load power; typical values

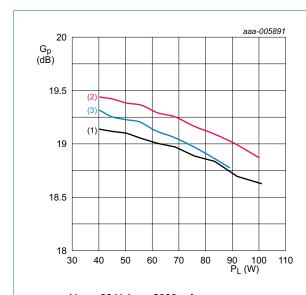


 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 10. Input return loss as a function of load power; typical values

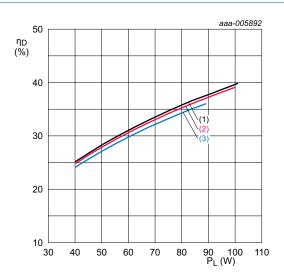
7.4.4 2-Carrier W-CDMA



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170MHz

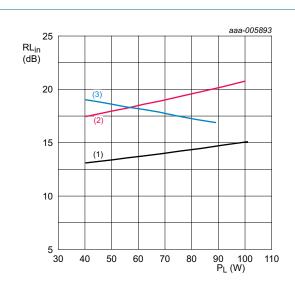
Fig 11. Power gain as a function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

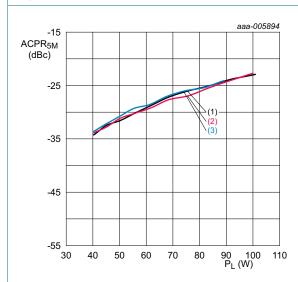
Fig 12. Drain efficiency as a function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

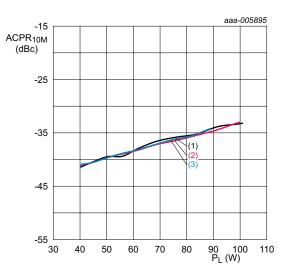
Fig 13. Input return loss as a function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 14. Adjacent channel power ratio (5 MHz) as a function of load power; typical values



 $V_{DS} = 28 \text{ V}; I_{Dq} = 2000 \text{ mA}.$

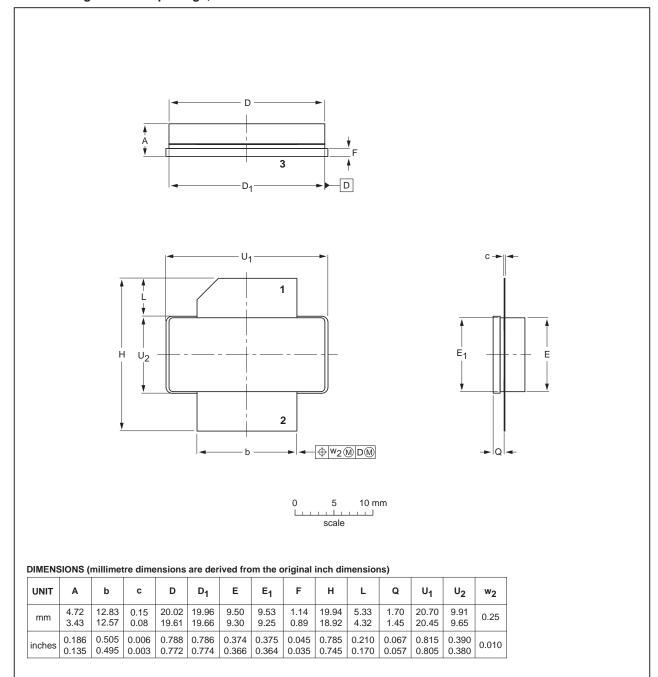
- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

Fig 15. Adjacent channel power ratio (10 MHz) as a function of load power; typical values

8. Package outline

Earless flanged ceramic package; 2 leads

SOT502B



OUTLINE		REFER	ENCES	EUROPEAN	ICCUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT502B					07-05-09 12-05-02	

Fig 16. Package outline SOT502B

BLF8G22LS-240

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9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

10. Abbreviations

Table 10. Abbreviations

Acronym	Description	
3GPP	3rd Generation Partnership Project	
CCDF	Complementary Cumulative Distribution Function	
CW	Continuous Wave	
DPCH	Dedicated Physical CHannel	
LDMOS	Laterally Diffused Metal Oxide Semiconductor	
PAR	Peak-to-Average Ratio	
SMD	Surface Mounted Device	
VSWR	Voltage Standing Wave Ratio	
W-CDMA	Wideband Code Division Multiple Access	

11. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BLF8G22LS-240 v.3	20130307	Product data sheet	-	BLF8G22LS-240 v.2		
Modifications:	 The status of this document has been changed to Product data sheet. 					
	 Table 1 on 	page 1: changed value of	η_D from 28 to 28.5	5		
	 Table 7 on 	page 3: changed typical v	alue of η_D from 28	to 28.5 and RL_{in} from -10 to -17 .		
BLF8G22LS-240 v.2	20130122 Preliminary data sheet - BLF8G22LS-240 v.1					
BLF8G22LS-240 v.1	20121211	Objective data sheet	-	-		

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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14. Contents

1	Product profile	1
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
2	Pinning information	2
3	Ordering information	2
4	Limiting values	2
5	Thermal characteristics	2
6	Characteristics	3
7	Test information	3
7.1	Ruggedness in class-AB operation	3
7.2	Impedance information	
7.3	Test circuit	
7.4	Graphical data	5
7.4.1	Pulsed CW	5
7.4.2	CW	_
7.4.3	1-Carrier W-CDMA	
7.4.4	2-Carrier W-CDMA	7
8	Package outline	9
9	Handling information	10
10		10
11	Revision history	10
12	Legal information	11
12.1	_	11
12.2	Definitions	11
12.3	Disclaimers	11
12.4	Trademarks	12
13	Contact information	12
14	Contents	13

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